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# Nanoscale Inhomogeneities Mapping in Ga-Modified Arsenic Selenide Glasses



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## Abstract

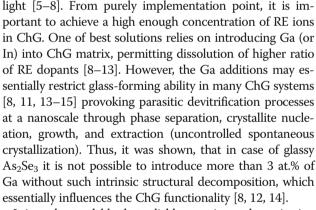
Nanoscale inhomogeneities mapping in Ga-modified  $As_2Se_3$  glass was utilized exploring possibilities of nanoindentation technique using a Berkovitch-type diamond tip. Structural inhomogeneities were detected in  $Ga_x(As_{0.40}Se_{0.60})_{100-x}$  alloys with more than 3 at.% of Ga. The appeared  $Ga_2Se_3$  nanocrystallites were visualized in Ga-modified arsenic selenide glasses using scanning and transmission electron microscopy. The Ga additions are shown to increase nanohardness and Young's modulus, this effect attaining an obvious bifurcation trend in crystallization-decomposed  $Ga_5(As_{0.40}Se_{0.60})_{95}$  alloy.

Keywords: Arsenic selenide glass, Nanoindentation, Crystallization, Phase separation

## Background

Chalcogenide glasses (ChG), e.g., chemical compounds of chalcogens (S, Se, or Te, but not O) with some elements from IV–V groups of the Periodic table (such as As, Sb, Ge, Bi) prepared by rapid quenching from a melt have found widespread application in modern photonics and optoelectronics because of their superior transmittance in IR domain ranged from visible to nearly 20– 25  $\mu$ m [1–3]. This important class of disordered materials sometimes distinguished as functional media of chalcogenide photonics [4] can be well-represented by several canonical systems (model glass-formers), where arsenic triselenide As<sub>2</sub>Se<sub>3</sub> (i.e., As<sub>40</sub>Se<sub>60</sub> as classified in specialized glass-chemistry terminology) in the form of meltquenched bulky rods, drawn fibers, deposited, or sputtered thin films, etc. plays a crucial role [1–4].

For a long time, these  $As_2Se_3$ -type ChG have been preferentially used as passive photonics elements, only transmitting light from one point to another. In the last decades, it was shown that due to purposeful rare-earth (RE) doping, these glasses could be also employed for a number of very important active device applications [3, 4]. In this case, the mid-IR light can be initiated by emission of excited RE ions (such as  $Pr^{3+}$ ,  $Er^{3+}$ ,  $Dy^{3+}$ ,  $Tb^{3+}$ ) on



different wavelengths, thus creating the remote sources of

It is understandable that reliable experimental monitoring of such nanoscale inhomogeneities in Ga-modified ChG is very important problem in the engineering of modern chalcogenide photonics. In this work, such methodology based on nanoindentation mapping supported by a number of electron microscopy visualization techniques will be examined at the example of Ga-modified As<sub>2</sub>Se<sub>3</sub> glasses.

## Methods

Conventional melt-quenching technique was employed to prepare  $Ga_x(As_{0.40}Se_{0.60})_{100-x}$  (x = 0\_5) samples using high purity commercial elemental precursors of Ga (7N), As (5N), and Se (5N) [12–14]. The As and Se were specially purified by distillation with low evaporation



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rate to remove impurities such as oxygen, water, silica, and carbon. The appropriate amounts of initial elements with total weight of 30 g were introduced into a silica tube of 10 mm in diameter. The ampoule was sealed under vacuum and heated up to 900 °C in a rocking furnace for 10 h followed by quenching into water from 700 °C. After quenching, the samples were swiftly moved to preheated furnace for annealing for 5 h at the temperature of 10 °C below glass transition temperature (to remove mechanical strains induced by fast quenching). The obtained rods were cut into disks of ~2 mm in thickness and polished to high optical quality.

The method of *nanoindentation mapping* [16] was probed as a tool to disclose possible nanoscale inhomogeneities caused by Ga additions in As<sub>40</sub>Se<sub>60</sub> glass. The values of nanohardness (NHD) and reduced elastic modulus (the Young's modulus *E*) were detected with a help of CSM nanoindentation instrument (CSM Instruments SA, Peseux, Switzerland) equipped with a pyramidal Berkovitch-type diamond tip with a radius of about 100 nm employing the known Oliver-Pharr method [17] for data analysis. The standard samples of fused silica with elastic modulus of 73 GPa and Poisson's ratio of 0.17 were used for indenter calibration allowing reliable load and displacement resolution at the level of 10 nN and 0.1 nm, respectively. The trapezoidal load-displacement curves (as those shown in Fig. 1 for As<sub>40</sub>Se<sub>60</sub> and Ga<sub>3</sub>(As<sub>0.40</sub>Se<sub>0.60</sub>)<sub>97</sub> glasses) were detected simultaneously for maximal load of 10 mN and loading-unloading rate of 20 mN/min, the dwell time at maximal loading being set to 15 s.

The tested sample's surface was scanned within a uniform grid of nanoindentation series (incl. 7–10 separate measurements). Such arranged experimental measuring protocol allows a quite acceptable locality of each measuring test, eliminating an influence of indentation-

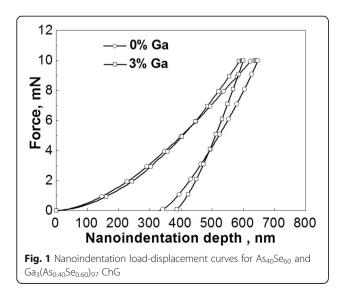
size effects [18–20]. The values of NHD and Young's modulus E were statistically averaged for each series and a whole sample's surface in final.

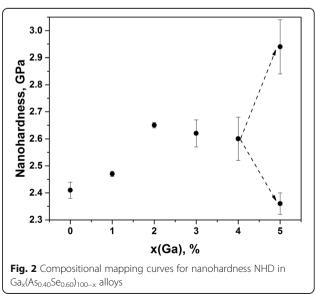
The surface morphology of fresh cut-sections of the prepared alloys was additionally visualized using scanning electron microscope (SEM) with energy-dispersive X-ray spectroscopy (EDS) analyzer FEI QUANTA 3D 200i. The transmission electron microscopy studies with primary electron beam accelerated by 200 kV voltage were performed with a FEI Tecnai Osiris device.

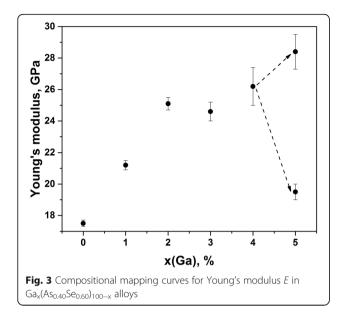
## **Results and Discussion**

In respect to our previous research on melt-quenched alloys in  $Ga_x(As_{0.40}Se_{0.60})_{100-x}$  system [8, 12, 14], the phase decomposition processes accompanied by  $Ga_2Se_3$  crystallization occur at 4 at.% of Ga. Thus, glasses with no more than 3 at.% of Ga were suggested to be successfully used for further RE doping [8]. The results of nano-indentation mapping presented on Fig. 2 confirm the homogeneity in these ChG via NHD and Young's modulus *E* measurements. With Ga content, both of these parameters show eventual growing tendency as it is character for other homogeneous glassy alloys affected by dopants which increase density.

It is known that structural evolution in glassy  $As_{40}Se_{60}$  at small amount of Ga added [14] is preferentially governed by appearance of  $As_2Se_{4/2}$  blocks based on homonuclear As–As covalent chemical bonds in a glassy network, which overbalance Ga-centered polyhedral units (GaSe<sub>4/2</sub> tetrahedrons). Such processes occur under growing input of atomic-deficient volumes contributing from bond-free solid angles around neighboring Se atoms terminated  $As_2Se_{4/2}$  fragments. This void agglomeration trend is quickly saturated







with Ga additions in ChG, thus facilitating mechanical freedom for gathering of Ga-based units. The partially decomposed Ga<sub>4</sub>(As<sub>0.40</sub>Se<sub>0.60</sub>)<sub>96</sub> alloy display an obvious increase of scattering in the NHD (Fig. 2) and Young's modulus *E* (Fig. 3) values. The drastic changes in the nanoindentation mapping are character for higher Ga content, just in Ga<sub>5</sub>(As<sub>0.40</sub>Se<sub>0.60</sub>)<sub>95</sub> alloy. Both the NHD and *E* parameters are essentially bifurcated in multiple measuring series of indentation test-ing. The down level of bifurcation is more or less tightly grouped around some averaged values (NHD = 2.36 GPa and *E* = 19.5 GPa), which are very close to those observed in As<sub>40</sub>Se<sub>60</sub> glass, while the upper level

is more roughly shifted, especially for Young's modulus *E*. Noteworthy, with activation of crystallization in  $Ga_4(As_{0.40}Se_{0.60})_{96}$  and  $Ga_5(As_{0.40}Se_{0.60})_{95}$  alloys, the character of free-volume void evolution is drastically changed, and now void fragmentation prevails due to stabilizing relaxation of growing  $Ga_2Se_3$  crystallites [14].

The surface morphology of fresh cut-sections of these alloys were visualized with the help of electron microscopy to identify the appeared  $Ga_2Se_3$  crystallites.

In Ga<sub>4</sub>(As<sub>0.40</sub>Se<sub>0.60</sub>)<sub>96</sub> alloy, these crystallites represent an agglomeration of tightly connected separate pieces extended over 200–300 nm (see Fig. 4a). The EDS spectroscopy performed in scattered electrons of all constituting elements (Fig. 4b–d) allows reliable identification of crystallites composition, i.e., Ga<sub>2</sub>Se<sub>3</sub> which is in excellent respect to the XRD data [8, 14]. Such crystallites cannot essentially affect nanoindentation mapping over a whole sample's surface because of comparative sizes with indenter imprints, but they eventually enhance scattering in the NHD and Young's modulus E values.

In contrast, the Ga<sub>2</sub>Se<sub>3</sub> crystallites in Ga<sub>5</sub>(As<sub>0.40</sub>Se<sub>0.60</sub>)<sub>95</sub> alloy get grown to larger µm sizes (Fig. 5). Under nearly uniform random distribution of such flower-like Ga<sub>2</sub>Se<sub>3</sub> crystallite agglomerates (as it shown in Fig. 5), they left large spaces of ChG in a homogeneous glassy state. Of course, this glass is slightly enriched on As, but still close to undoped stoichiometric As<sub>2</sub>Se<sub>3</sub>. As a result, the bifurcation effect is observed in nanoindentation mapping, giving two groups of NHD and Young's modulus *E* data.

## Conclusions

Mapping of nanoscale inhomogeneities in Ga-modified As<sub>2</sub>Se<sub>3</sub> glassy alloy was utilized exploring possibilities of

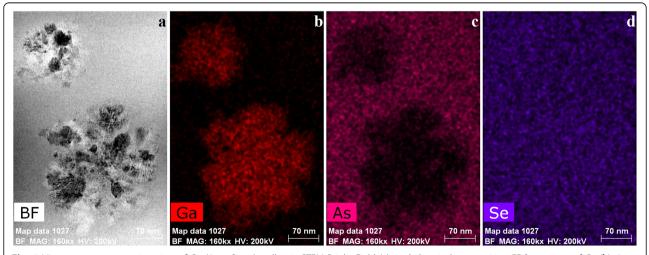
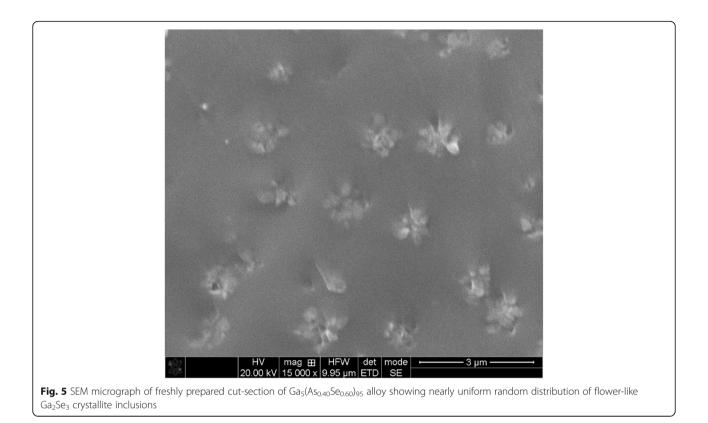


Fig. 4 Microstructure cut-section view of Ga<sub>4</sub>(As<sub>0.40</sub>Se<sub>0.60</sub>)<sub>96</sub> alloy in STEM Bright Field (**a**), and chemical composition EDS mapping of Ga (**b**), As (**c**), and Se (**d**)



conventional nanoindentation technique equipped with a Berkovitch-type diamond tip. Structural inhomogeneities were detected in  $Ga_x(As_{0.40}Se_{0.60})_{100-x}$ alloys having more than 3 at.% of Ga. The appearance of  $Ga_2Se_3$  nanocrystallites was separately visualized in Ga-modified arsenic selenide glass using scanning and transmission electron microscopy. The Ga additions are shown to increase nanohardness and Young's modulus of glasses, this effect attaining an obvious bifurcation trend in crystallization-decomposed  $Ga_5(As_{0.40}Se_{0.60})_{95}$  alloy.

#### Abbreviations

ChG: Chalcogenide glass; EDS: Energy-dispersive X-ray spectroscopy; NHD: Nanohardness; RE: Rare-earth; SEM: Scanning electron microscope

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## Authors' Contributions

YS initiated the research, performed the synthesis of the tested objects, and drafted the manuscript. YS, JC, and WB designed the experimental strategy. SA, JS, and YS performed the nanoindentation measurements and data analysis. AD and WB performed the TEM, SEM, and EDS analysis. JC gave some advices on the work. All authors read and approved the final manuscript.

#### **Competing Interests**

The authors declare that they have no competing interests.

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